

MBM600E17D

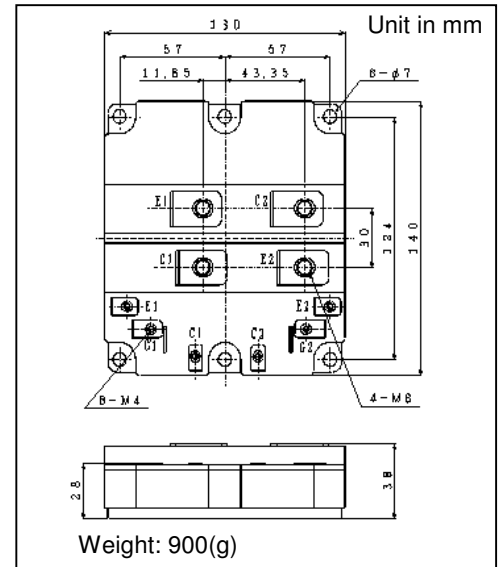
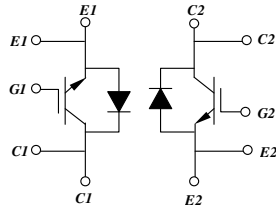
Silicon N-channel IGBT

OUTLINE DRAWING

1. FEATURES

- * High speed, low loss IGBT module.
- * Low driving power due to low input capacitance MOS gate.
- * Low noise due to ultra soft fast recovery diode.
- * High reliability, high durability module.
- * High thermal fatigue durability.
($\Delta T_c=70^\circ\text{C}$, $N>30,000$ cycles)
- * Isolated heat sink (terminal to base).

CIRCUIT DIAGRAM



2. ABSOLUTE MAXIMUM RATINGS ($T_c=25^\circ\text{C}$)

Item	Symbol	Unit	MBM600E17D
Collector Emitter Voltage	V_{CES}	V	1,700
Gate Emitter Voltage	V_{GES}	V	± 20
Collector Current	DC	I_C	600
	1ms	I_{Cp}	1,200
Forward Current	DC	I_F	600
	1ms	I_{FM}	1,200
Junction Temperature	T_j	$^\circ\text{C}$	-40 ~ +125
Storage Temperature	T_{stg}	$^\circ\text{C}$	-40 ~ +125
Isolation Voltage	V_{ISO}	V_{RMS}	4,000(AC 1 minute)
Screw Torque	Terminals (M4/M8)	-	2/15 (1)
	Mounting (M6)	-	6 (2)

Notes: (1) Recommended Value $1.8 \pm 0.2 / 15^{+0}_{-3}$ N·m

(2) Recommended Value 5.5 ± 0.5 N·m

3. ELECTRIC CHARACTERISTICS

Item	Symbol	Unit	Min.	Typ.	Max.	Test Conditions
Collector Emitter Cut-Off Current	I_{CES}	mA	-	-	5.0	$V_{CE}=1,700\text{V}$, $V_{GE}=0\text{V}$, $T_j=25^\circ\text{C}$
			-	5	17	$V_{CE}=1,700\text{V}$, $V_{GE}=0\text{V}$, $T_j=125^\circ\text{C}$
Gate Emitter Leakage Current	I_{GES}	nA	-500	-	+500	$V_{GE}=\pm 20\text{V}$, $V_{CE}=0\text{V}$, $T_j=25^\circ\text{C}$
Collector Emitter Saturation Voltage	$V_{CE(sat)}$	V	2.1	2.6	3.1	$I_C=600\text{A}$, $V_{GE}=15\text{V}$, $T_j=125^\circ\text{C}$
Gate Emitter Threshold Voltage	$V_{GE(TH)}$	V	5.0	6.5	8.0	$V_{CE}=10\text{V}$, $I_C=60\text{mA}$, $T_j=25^\circ\text{C}$
Input Capacitance	C_{ies}	nF	-	50	-	$V_{CE}=10\text{V}$, $V_{GE}=0\text{V}$, $f=100\text{kHz}$, $T_j=25^\circ\text{C}$
Internal Gate Resistance	$R_{g(int)}$	Ω	-	1.6	-	
Switching Times	Rise Time	t_r	0.25	0.5	1.0	$V_{CC}=900\text{V}$, $I_C=600\text{A}$ $L=100\text{nH}$, $C_{GE}=68\text{nF}$ (3) $R_G=1.5\Omega$ (3) $V_{GE}=\pm 15\text{V}$, $T_j=125^\circ\text{C}$
	Turn On Time	t_{on}	0.4	0.8	1.6	
	Fall Time	t_f	0.25	0.5	1.0	
	Turn Off Time	t_{off}	0.75	1.5	3.0	
Peak Forward Voltage Drop	V_{FM}	V	1.4	1.9	2.3	$I_F=600\text{A}$, $V_{GE}=0\text{V}$, $T_j=125^\circ\text{C}$
Reverse Recovery Time	t_{rr}	μs	0.1	0.5	1.0	$V_{CC}=900\text{V}$, $I_C=600\text{A}$, $L=100\text{nH}$, $C_{GE}=68\text{nF}$ (3)
Turn On Loss	$E_{on(10\%)}$	J/P	-	0.13	0.2	$R_G=1.5\Omega$ (3)
Turn Off Loss	$E_{off(10\%)}$	J/P	-	0.2	0.3	$V_{GE}=\pm 15\text{V}$, $T_j=125^\circ\text{C}$
Reverse Recovery Loss	$E_{rr(10\%)}$	J/P	-	0.2	0.3	
Thermal Impedance	IGBT	$R_{th(j-c)}$	-	-	0.038	Junction to case
	FWD	$R_{th(j-c)}$	-	-	0.060	
Contact Thermal Impedance	$R_{th(c-f)}$	K/W	-	0.016	-	Case to fin (per 1 arm)

Notes:(3) R_G value is a test condition value for evaluation, not recommended value.

Please, determine the suitable R_G value by measuring switching behaviors.

- * Please contact our representatives at order.
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